

Search Notes

Application/Control No.

10/633,620

Examiner

Quynh H. Nguyen

Applicant(s)/Patent under
Reexamination

KATO ET AL.

Art Unit

2614

SEARCHED

Class	Subclass	Date	Examiner
379	90.01 93.01 93.09 210.01 230	4/27/07	QN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Searched: East, USPGPub, USPAT, EPO, JPO	4/27/07	QN
Inventor search in PALM database	4/27/07	QN